International Rectifier

- Adavanced Process Technology
- Ultra Low On-Resistance
- P-Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free

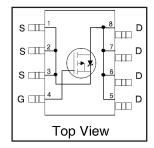
Description

Fourth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and dual-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

IRF7204PbF

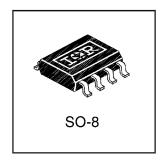
HEXFET® Power MOSFET



$$V_{DSS} = -20V$$

$$R_{DS(on)} = 0.060\Omega$$

$$I_{D} = -5.3A$$



Absolute Maximum Ratings

| | _ | | | |
|--|---|--------------|-------|--|
| Parameter | | Max. | Units | |
| I _D @ T _A = 25°C | Continuous Drain Current, V _{GS} @ 10V | -5.3 | | |
| I _D @ T _A = 70°C | Continuous Drain Current, V _{GS} @ 10V | -4.2 | Α | |
| I _{DM} | Pulsed Drain Current ① | -21 | | |
| P _D @T _C = 25°C | Power Dissipation | 2.5 | W | |
| | Linear Derating Factor | 0.020 | W/°C | |
| V_{GS} | Gate-to-Source Voltage | ± 12 | V | |
| dv/dt | Peak Diode Recovery dv/dt ② | -1.7 | V/nS | |
| T _{J,} T _{STG} | Junction and Storage Temperature Range | -55 to + 150 | ∞ | |

Thermal Resistance Ratings

| | Parameter | Min. | Тур. | Max. | Units |
|-----------------|-------------------------------|------|------|------|-------|
| $R_{\theta JA}$ | Maximum Junction-to-Ambient ④ | | | 50 | °C/W |

IRF7204PbF

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|---------------------------------|--|------|--------|-------|-------|---|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | -20 | | | V | $V_{GS} = 0V, I_{D} = -250\mu A$ |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | | -0.022 | | V/°C | Reference to 25°C, I _D = -1mA |
| В | Static Drain-to-Source On-Resistance | | | 0.060 | Ω | V _{GS} = -10V, I _D = -5.3A ③ |
| R _{DS(ON)} | Static Dialit-to-Source Off-Resistance | | | 0.10 | 52 | $V_{GS} = -4.5V$, $I_D = -2.0A$ ③ |
| V _{GS(th)} | Gate Threshold Voltage | -1.0 | | -2.5 | V | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ |
| g _{fs} | Forward Transconductance | | 7.9 | | S | V _{DS} = -15V, I _D = -5.3A ③ |
| 1 | During to Common Lorder to Commont | | | -25 | | V _{DS} = -16V, V _{GS} = 0V |
| IDSS | Drain-to-Source Leakage Current | | | -250 | μΑ | V _{DS} = -16V, V _{GS} = 0V, T _J = 125 °C |
| Lead | Gate-to-Source Forward Leakage | | | -100 | nA | V _{GS} = -12V |
| I _{GSS} | Gate-to-Source Reverse Leakage | | | 100 | IIA | V _{GS} = 12V |
| Qg | Total Gate Charge | | 25 | | | I _D = -5.3A |
| Q _{gs} | Gate-to-Source Charge | | 5.0 | | nC | V _{DS} = -10V |
| Q _{gd} | Gate-to-Drain ("Miller") Charge | | 8.0 | | | V _{GS} = -10V ③ |
| t _{d(on)} | Turn-On Delay Time | | 14 | 30 | | V _{DD} = -10V |
| t _r | RiseTime | | 26 | 60 | no | $I_D = -1.0A$ |
| t _{d(off)} | Turn-Off Delay Time | | 100 | 150 | ns | $R_G = 6.0\Omega$ |
| t _f | Fall Time | | 68 | 100 | | $R_D = 10\Omega$ ③ |
| L _D | Internal Drain Inductance | | 2.5 | | nH | Between lead,6mm(0.25in.) |
| L _S | Internal Source Inductance | | 4.0 | _ | 1111 | from package and center of die contact |
| C _{iss} | Input Capacitance | | 860 | | | V _{GS} = 0V |
| Coss | Output Capacitance | | 750 | | pF | V _{DS} = -10V |
| C _{rss} | Reverse Transfer Capacitance | | 230 | | | f = 1.0MHz |

Source-Drain Ratings and Characteristics

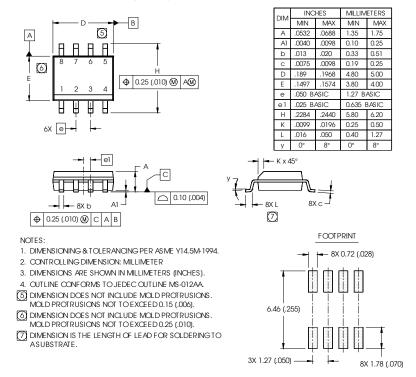
| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------|---------------------------|--|------|----------|-------------|--|
| ls | Continuous Source Current | | | 2.5 | | MOSFET symbol |
| | (Body Diode) | | 2.5 | 2.5 A | showing the | |
| I _{SM} | Pulsed Source Current | | 19 | -15 | A | integral reverse |
| | (Body Diode) ① | | | | | p-n junction diode. |
| V_{SD} | Diode Forward Voltage | | | -1.2 | V | $T_J = 25$ °C, $I_S = -1.25$ A, $V_{GS} = 0$ V ③ |
| t _{rr} | Reverse Recovery Time | | 85 | 100 | ns | $T_J = 25^{\circ}C$, $I_F = -2.4A$ |
| Q _{rr} | Reverse RecoveryCharge | | 77 | 120 | nC | di/dt = 100A/µs ③ |
| t _{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | |

Notes:

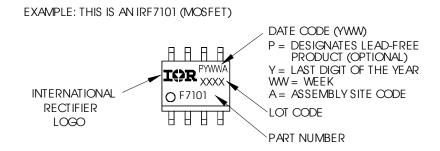
- ① Repetitive rating; pulse width limited by max. junction temperature.
- $\begin{tabular}{ll} \mathbb{Q} $I_{SD} \leq -5.3A, $di/dt \leq 90A/\mu s, $V_{DD} \leq V_{(BR)DSS},$ \\ $T_{J} \leq 150 ^{\circ}C$ \end{tabular}$
- 4 Surface mounted on FR-4 board, $t \leq 10$ sec.

SO-8 Package Outline

Dimensions are shown in milimeters (inches)



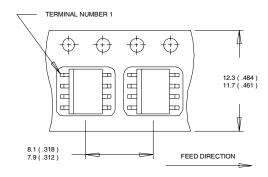
SO-8 Part Marking Information (Lead-Free)



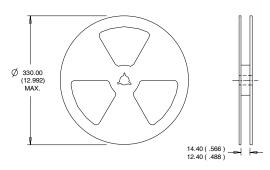
IRF7204PbF

SO-8 Tape and Reel

Dimensions are shown in milimeters (inches)



- NOTES:
 1. CONTROLLING DIMENSION: MILLIMETER.
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES:
 1. CONTROLLING DIMENSION: MILLIMETER.
 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualifications Standards can be found on IR's Web site.

